TOSHIBA CMOS Digital Integrated Circuit Silicon Monolithic

# TC4093BP,TC4093BF,TC4093BFN

### TC4093B Quad 2-Input NAND Schmitt Triggers

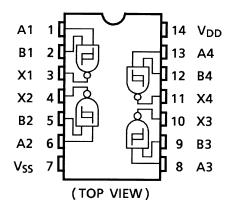
The TC4093B is a quad 2-input NAND gate having Schmitt trigger function for all the input terminals.

Since the circuit threshold voltage varies with rising time and falling time of the input waveform (VP and VN), this gate can be used for a wide variety of applications to line receivers, waveform shaping, astable multivibrators, monosatable multivibrators, etc.

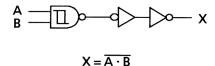
In addtion to regular NAND gates.

As the TC4093B and the TC4011B are identical in pin assignment, they are compatible each other.

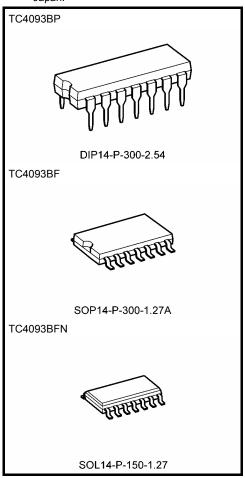
#### **Pin Assignment**



#### **Logic Diagram**



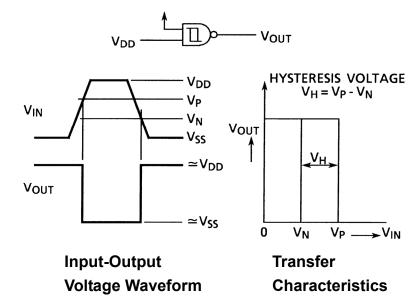
Note: xxxFN (JEDEC SOP) is not available in Japan.



Weight

DIP14-P-300-2.54 : 0.96 g (typ.) SOP14-P-300-1.27A : 0.18 g (typ.) SOL14-P-150-1.27 : 0.12 g (typ.)

### **Input-Output Characteristic**



### **Absolute Maximum Ratings (Note)**

Characteristics	Symbol	Rating	Unit
DC supply voltage	$V_{DD}$	V <sub>SS</sub> – 0.5~V <sub>SS</sub> + 20	V
Input voltage	V <sub>IN</sub>	V <sub>SS</sub> – 0.5~V <sub>DD</sub> + 0.5	V
Output voltage	V <sub>OUT</sub>	V <sub>SS</sub> - 0.5~V <sub>DD</sub> + 0.5	V
DC input current	I <sub>IN</sub>	±10	mA
Power dissipation	PD	300 (DIP)/180 (SOIC)	mW
Operating temperature range	T <sub>opr</sub>	-40~85	°C
Storage temperature range	T <sub>stg</sub>	−65 <b>~</b> 150	°C

Note: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

### **Operating Ranges (V<sub>SS</sub> = 0 V) (Note)**

Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
DC supply voltage	$V_{DD}$	_	3	_	18	V
Input voltage	V <sub>IN</sub>	_	0	_	$V_{DD}$	V

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Note: The operating ranges must be maintained to ensure the normal operation of the device. Unused inputs must be tied to either  $V_{DD}$  or  $V_{SS}$ .



# Static Electrical Characteristics ( $V_{SS} = 0 V$ )

		Sym-	Test Condition		-40°C		25°C			85°C		
Charac	teristics	bol		V <sub>DD</sub> (V)	Min	Max	Min	Тур.	Max	Min	Max	Unit
		V <sub>OH</sub>	I <sub>OUT</sub>   < 1 μA	5	4.95	_	4.95	5.00	_	4.95	_	
High-level output voltage	$V_{IN} = V_{SS}, V_{DD}$		10	9.95	_	9.95	10.00	_	9.95	_	V	
Ū			VIN - VSS, VDD	15	14.95	_	14.95	15.00	_	14.95	_	
			  I <sub>OUT</sub>   < 1 μA	5	_	0.05	_	0.00	0.05	_	0.05	
Low-level voltage	output	V <sub>OL</sub>	$V_{IN} = V_{DD}$	10	_	0.05	_	0.00	0.05	_	0.05	V
J			VIN - VDD	15	_	0.05	—	0.00	0.05	—	0.05	
			V <sub>OH</sub> = 4.6 V	5	-0.61	_	-0.51	-1.0	_	-0.42	_	
			V <sub>OH</sub> = 2.5 V	5	-2.50	_	-2.10	-4.0	_	-1.70	_	
Output hig	h current	IOH	V <sub>OH</sub> = 9.5 V	10	-1.50	_	-1.30	-2.2	_	-1.10	_	mA
			V <sub>OH</sub> = 13.5 V	15	-4.00	_	-3.40	-9.0	_	-2.80	_	
			$V_{IN}=V_{SS},V_{DD}$									
		I <sub>OL</sub>	V <sub>OL</sub> = 0.4 V	5	0.61	_	0.51	1.5	_	0.42	_	
Output lov	. aurrant		$V_{OL} = 0.5 V$	10	1.5	_	1.30	3.8	_	1.10	_	mA
Output lov	v current		V <sub>OL</sub> = 1.5 V	15	4.0	_	3.40	15.0	_	2.80	_	MA
			$V_{IN} = V_{DD}$									
			V <sub>OUT</sub> = 0.5 V, 4.5 V	5	_	_	2.05	2.8	3.55	_	_	
High thres voltage	hold	V <sub>P</sub>	$V_{OUT} = 1.0 \text{ V}, 9.0 \text{ V}$	10	_	_	4.10	5.3	7.00	_	_	V
voltage			V <sub>OUT</sub> = 1.5 V, 13.5 V	15	_	_	6.20	7.8	10.40	_	_	
			V <sub>OUT</sub> = 0.5 V, 4.5 V	5	_	_	1.5	2.3	3.15	_	_	
Low threst voltage	hold	V <sub>N</sub>	$V_{OUT} = 1.0 \text{ V}, 9.0 \text{ V}$	10	_	_	3.2	4.5	6.30	_	_	V
			$V_{OUT} = 1.5 \text{ V}, 13.5 \text{ V}$	15	_	_	4.8	6.6	9.30	_	_	
			_	5	_	_	0.20	0.5	0.85	_	_	
Hysteresis voltage		V <sub>H</sub>		10	_	_	0.30	0.8	1.40	_	_	V
				15	_	_	0.45	1.2	1.90	_	_	
Input	"H" level	l <sub>IH</sub>	V <sub>IH</sub> = 18 V	18		0.1	_	10 <sup>-5</sup>	0.1	_	1.0	
current	"L" level	IJL	V <sub>IL</sub> = 0 V	18	_	-0.1	_	-10 <sup>-5</sup>	-0.1	_	-1.0	μΑ
	·			5	_	1	_	0.001	1	_	7.5	
Quiescent current	Quiescent supply		$V_{IN} = V_{SS}, V_{DD}$	10	_	2	_	0.002	2	_	15.0	μА
34.13111			(Note)	15		4		0.004	4	_	30.0	

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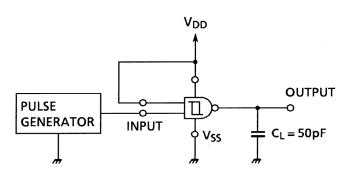
Note: All valid input combinations.

# Dynamic Electrical Characteristics (Ta = 25°C, $V_{SS}$ = 0 V, $C_L$ = 50 pF)

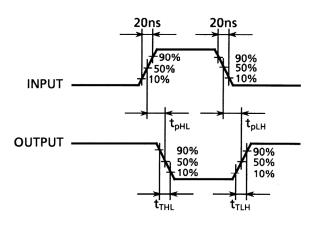
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit	
Output transition time (low to high)			V <sub>DD</sub> (V)	_	80	200	
	tтLН	_	10 15	_	50 40	100 80	ns
Output transition time (high to low)	t <sub>THL</sub>	_	5 10 15	_ _ _	80 50 40	200 100 80	ns
Propagation delay time	t <sub>pLH</sub>	_	5 10 15	_ _ _	130 60 40	260 120 80	ns
Input capacitance	C <sub>IN</sub>	_	•	_	5	7.5	pF

### **Circuit and Waveform for Measurement of Dynamic Characteristics**

### Circuit Waveform

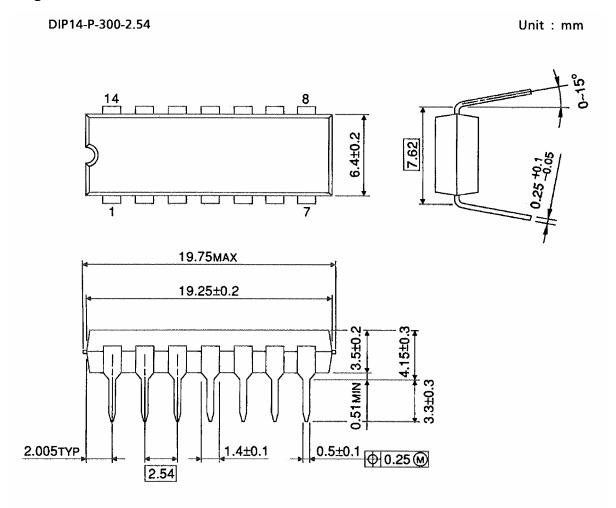


DUTY RATIO = 50%, f = 500kHz





# **Package Dimensions**

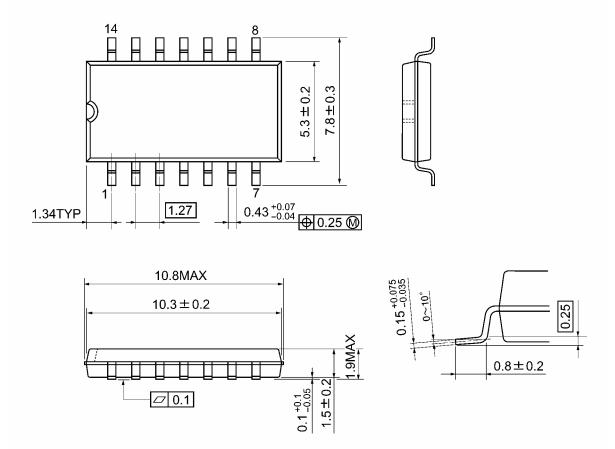


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Weight: 0.96 g (typ.)

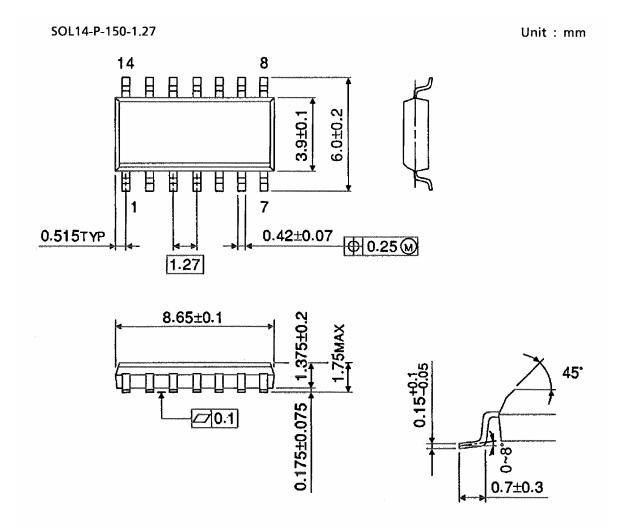
# **Package Dimensions**

SOP14-P-300-1.27A Unit: mm



Weight: 0.18 g (typ.)

# **Package Dimensions (Note)**



Note: This package is not available in Japan.

Weight: 0.12 g (typ.)

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20070701-EN GENERAL

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